



INTERNATIONAL INTELLECTUAL  
PROPERTY TRAINING INSTITUTE



Korean Intellectual  
Property Office



**WIPO**  
WORLD  
INTELLECTUAL PROPERTY  
ORGANIZATION

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## WORKSHOP

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**WIPO/PCT/DAE/17/INF.1 PROV**  
**ORIGINAL: ENGLISH**  
**DATE: JULY 3 TO 7, 2017**

## Examination in the PCT National Phase

organized by  
the World Intellectual Property Organization (WIPO)

in cooperation with  
the International Intellectual Property Training Institute (IIPTI) of the  
Republic of Korea

with the assistance of  
the Korean Intellectual Property Office (KIPO)

**Daejeon and Seoul, JULY 3 to 7, 2017**

## PROGRAM

*prepared by the WIPO, IIPTI and KIPO*

Monday, July 3, 2017

11.00 – 11.30 Arrival and Registration

11.30 – 13.30 Lunch Break

13.30 – 14.00 Opening Ceremony

Welcome addresses by:

The representative of the International Intellectual Property Training Institute (IIPTI), Daejeon, Republic of Korea

Mr. Ken Natsume, Director, PCT International Cooperation Division, Patents and Technology Sector, World Intellectual Property Organization (WIPO), Geneva, Switzerland

14.00 – 15.00 **Topic 1 Examination in the PCT International Phase and Challenges for National Phase Examination**

Speaker: Mr. Ken-Ichiro Natsume  
Director, PCT International Cooperation Division,  
Patents and Technology Sector, WIPO

15.00 – 17.00 **Topic 2 Lessons Learned from Analyses of PCT National Phase Examination and Backlog Processing in Several Jurisdictions**

Speaker: Mr. Lutz Mailänder  
Head, Cooperation on Examination and Training  
Section, PCT International Cooperation Division,  
Patents and Technology Sector, WIPO

17.00 – 18.00 **Topic 3 KIPO Activities to Support IP Awareness and Capacity in Developing Countries**

Speaker: Mr. Hyun-Suk Lim  
Director, Multilateral Affairs Division, Intellectual  
Property Protection & International Cooperation  
Bureau, KIPO

Tuesday, July 4, 2017

09.00 – 12.00 **Topic 4 Country Reports and Discussion – Patent Examination Practices in the National Phase and Experiences Using Examination Results from the International Phase and other National Phases**

Moderator: Ms. Weonhye Shin  
Senior Deputy Director, Biotechnology  
Examination Division, Patent Examination  
Bureau III

Presentations: All Participants

12.00 – 14.00 Lunch Break

14.00 – 15.00 **Topic 5 Patent Family Concepts and Sources of Patent Family Information**

Speaker: Mr. Lutz Mailänder

15.00 – 17.00 **Hands-on Case Studies Topic 5 and Discussion**

Wednesday, July 5, 2017

9.00 – 10.00 **Topic 6 Examination Status in other Jurisdictions and Retrieval of Examination Work Products (Global Dossier)**

Speaker: Mr. Lutz Mailänder

10.00 – 12.00 **Hands-on Case Studies Topic 6 and Discussion**

12.00 – 14.00 Lunch Break

14.00 – 15.00 **Topic 7 National Phase Examination at KIPO and KIPO's Experience with PPH**

Speaker: Mr. Ju-Chull Han  
Deputy Director, Patent System Administration  
Division, Patent Examination Policy Bureau, KIPO

15.00 – 15.30 **Topic 8 Issues with Utilizing Claims Granted in Other Jurisdictions**

Speaker: Mr. Lutz Mailänder

15.30 – 17.00 **Hands-on Case Studies Topic 8 and Discussion**

Thursday, July 6, 2017

9.00 – 10.00 **Topic 9 Retrieving and Comparing Prior Art Citations (Common Citation Documents)**

Speaker: Mr. Lutz Mailänder

10.00 – 12.00 **Hands-on Case Studies Topic 9 and Discussion**

12.00 – 14.00 Lunch Break

14.00 – 17.00 **Topic 10 Case Studies: Retrieving and Utilizing External Examination Results for Selected Pending Cases**

Speaker: Ms. Weonhye Shin

Friday, July 7, 2017

9.00 – 10.00		<b>Discussion of Case Studies</b>
10.00 – 11.00	<b>Topic 11</b>	<b>Wrap-up of the Workshop: Options for Backlog Processing and Work-Sharing</b> <b>Discussion: What is needed for effective Work-sharing?</b>  Moderator: Mr. Ken-Ichiro Natsume
11.00 – 12.00		<b>Final Assessment Test and Evaluation</b>
12.00 – 13.30	Lunch	
13.30 – 14.00	Closing Ceremony	
14.00 –	Transfer to Seoul	

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